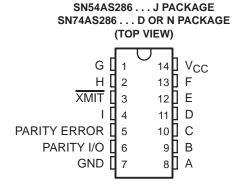
- Generate Either Odd or Even Parity for Nine Data Lines
- Cascadable for n-Bit Parity
- Direct Bus Connection for Parity Generation or Checking by Using the Parity I/O Port
- Glitch-Free Bus During Power Up/Down
- Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

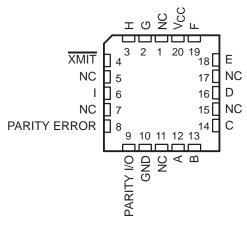
#### description

The SN54AS286 and SN74AS286 universal 9-bit parity generators/checkers feature a local output for parity checking and a 48-mA bus-driving parity input/output (I/O) port for parity generation/checking. The word-length capability is easily expanded by cascading.

The transmit (XMIT) control input is implemented specifically to accommodate cascading. When XMIT is low, the parity tree is disabled and PARITY ERROR remains at a high logic level regardless of the input levels. When XMIT is high, the parity tree is enabled. PARITY ERROR indicates a parity error when either an even number of inputs (A–I) are high and PARITY I/O is forced to a low logic level, or when an odd number of inputs are high and PARITY I/O is forced to a high logic level.



SN54AS286 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

The I/O control circuitry was designed so that the I/O port remains in the high-impedance state during power up or power down to prevent bus glitches.

The SN54AS286 is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to  $125^{\circ}$ C. The SN74AS286 is characterized for operation from  $0^{\circ}$ C to  $70^{\circ}$ C.

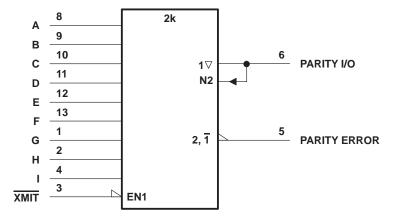
#### **FUNCTION TABLE**

NUMBER OF INPUTS (A-I) THAT ARE HIGH	XMIT	PARITY I/O	PARITY ERROR
0, 2, 4, 6, 8	I	Н	Н
1, 3, 5, 7, 9	1	L	Н
0.0400	h	h	Н
0, 2, 4, 6, 8	h	I	L
12570	h	h	L
1, 3, 5, 7, 9	h	1	Н

h = high input level H = high output level I = low input level L = low output level

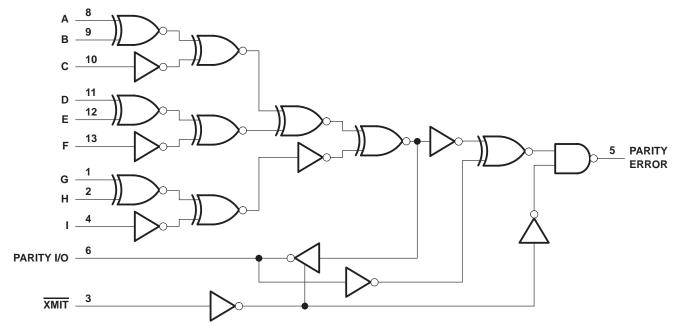
TEXAS INSTRUMENTS

# logic symbol†



 $<sup>^\</sup>dagger$  This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, and N packages.

# logic diagram (positive logic)



Pin numbers shown are for the D, J, and N packages.



### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V <sub>CC</sub>	
Input voltage, V <sub>I</sub>	
Voltage applied to a disabled 3-state output	
Operating free-air temperature range, T <sub>A</sub> : SN54AS286	–55°C to 125°C
SN74AS286	0°C to 70°C
Storage temperature range	-65°C to 150°C

#### recommended operating conditions

			SI	SN54AS286			SN74AS286		
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage		2			2			V
VIL	Low-level input voltage			0.8			8.0	V	
	I Pale I and and an annual	PARITY ERROR			-2			-2	4
ІОН	High-level output current	PARITY I/O			-12			-15	mA
loL		PARITY ERROR			20			20	
	Low-level output current PARITY I/O				32			48	mA
TA	T <sub>A</sub> Operating free-air temperature				125	0		70	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

			SN	54AS28	36	SN					
	PARAMETER	TEST CON	IDITIONS	MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT	
VIK		$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V	
	All outputs	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	V <sub>CC</sub> -2	1		V <sub>CC</sub> -2				
.,			$I_{OH} = -3 \text{ mA}$	2.4	2.9		2.4	3		.,	
VOH	PARITY I/O	V <sub>CC</sub> = 4.5 V	$I_{OH} = -12 \text{ mA}$	2.4						V	
			$I_{OH} = -15 \text{ mA}$				2.4				
	PARITY ERROR		I <sub>OL</sub> = 20 mA		0.35	0.5		0.35	0.5		
VOL	DA DITY I/O	V <sub>CC</sub> = 4.5 V	$I_{OL} = 32 \text{ mA}$			0.5				V	
	PARITY I/O		$I_{OL} = 48 \text{ mA}$						0.5		
	PARITY I/O	V 55V	V <sub>I</sub> = 5.5 V			0.1			0.1	A	
l <sub>l</sub>	All other inputs	V <sub>CC</sub> = 5.5 V	V <sub>I</sub> = 7 V			0.1			0.1	mA	
	PARITY I/O§	V 55V	557			50			50		
<sup>I</sup> IH	All other inputs	$V_{CC} = 5.5 \text{ V},$	$V_{  } = 2.7 \text{ V}$			20			20	μΑ	
	PARITY I/O§	I/O§				-0.5			-0.5	A	
ΊL	All other inputs	V <sub>CC</sub> = 5.5 V,	$V_{I} = 0.4 V$			-0.5			-0.5	mA	
IOI		V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.25 V	-30		-112	-30		-112	mA	
loo	Transmit	V			30	43		30	43	m 1	
Icc	Receive	V <sub>CC</sub> = 5.5 V			35	50		35	50	mA	

<sup>‡</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.



<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>§</sup> For I/O ports, the parameters I<sub>IH</sub> and I<sub>IL</sub> include the off-state output current.

# SN54AS286, SN74AS286 9-BIT PARITY GENERATORS/CHECKERS WITH BUS-DRIVER PARITY I/O PORT SDAS050B - DECEMBER 1983 - REVISED DECEMBER 1994

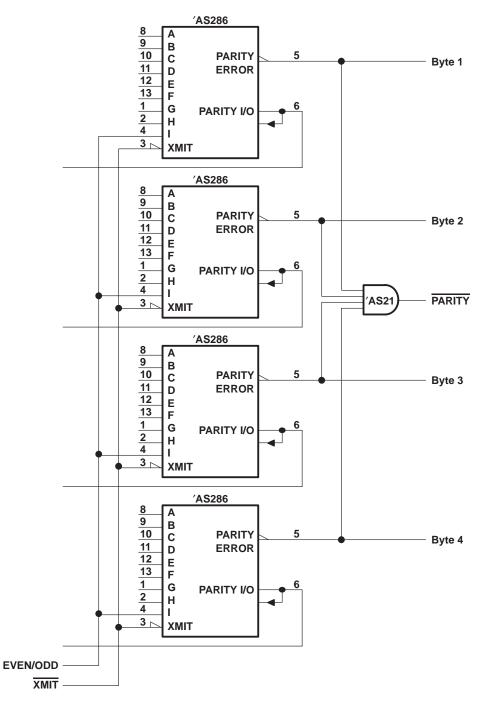
# switching characteristics (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>C</sub> C <sub>L</sub> R1 R2 T <sub>A</sub>	UNIT			
			SN54A		SN74AS286		
			MIN	MAX	MIN	MAX	
t <sub>PLH</sub>	Any A – I	PARITY I/O	3	17	3	15	ns
<sup>t</sup> PHL	Ally A – I	PARITY I/O	3	15	3	14	
<sup>t</sup> PLH	A A . I	DARITY EDDOR	3	20	3	16.5	
<sup>t</sup> PHL	Any A – I	PARITY ERROR	3	18	3	16.5	ns
<sup>t</sup> PLH	DA DITY I/O	DADITY EDDOD	3	10	3	9	ns
t <sub>PHL</sub>	PARITY I/O	PARITY ERROR	3	10	3	9	
<sup>t</sup> PZH	VA 41-	DARITYLIA	3	14	3	13	
t <sub>PZL</sub>	XMIT	PARITY I/O	3	17	3	16	ns
<sup>t</sup> PHZ	XMIT	PARITY I/O	3	13	3	11.5	no
<sup>t</sup> PLZ	AIVII I	FARITTI/O	3	11	3	10	ns

<sup>&</sup>lt;sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

#### **APPLICATION INFORMATION**

Figure 1 shows a 32-bit parity generator/checker with output polarity switching, parity-error detection, and parity on every byte.



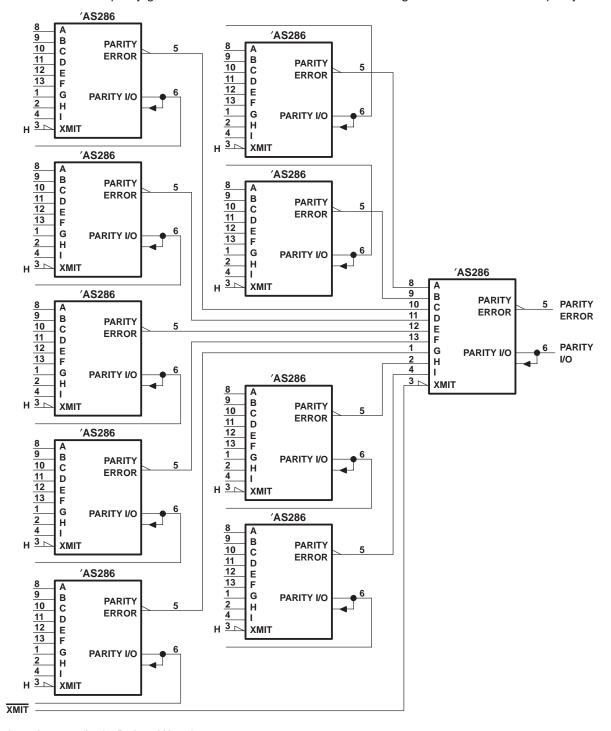
Pin numbers shown are for the D, J, and N packages.

Figure 1. 32-Bit Parity Generator/Checker



#### **APPLICATION INFORMATION**

Figure 2 shows a 90-bit parity generator/checker with XMIT on the last stage available for use with parity detection.

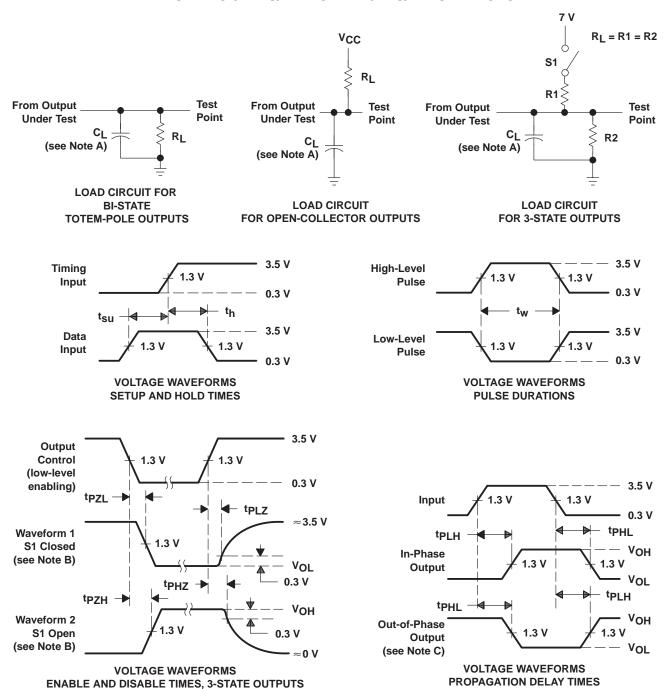


Pin numbers shown are for the D, J, and N packages.

Figure 2. 90-Bit Parity Generator/Checker With Parity-Error Detection



#### PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- All input pulses have the following characteristics: PRR  $\leq$  1 MHz,  $t_r = t_f = 2$  ns, duty cycle = 50%.
- The outputs are measured one at a time with one transition per measurement.

Figure 3. Load Circuits and Voltage Waveforms







10-Jun-2014

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
5962-8966301CA	ACTIVE	CDIP	J	14		TBD	Call TI	Call TI	-55 to 125		Samples
SN54AS286J	OBSOLETE	CDIP	J	14		TBD	Call TI	Call TI	-55 to 125		
SN74AS286D	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	AS286	Samples
SN74AS286DR	OBSOLETE	SOIC	D	14		TBD	Call TI	Call TI	0 to 70	AS286	
SN74AS286DRE4	OBSOLETE	SOIC	D	14		TBD	Call TI	Call TI	0 to 70		
SN74AS286DRG4	OBSOLETE	SOIC	D	14		TBD	Call TI	Call TI	0 to 70		
SN74AS286N	ACTIVE	PDIP	N	14	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	0 to 70	SN74AS286N	Samples
SN74AS286NE4	ACTIVE	PDIP	N	14	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	0 to 70	SN74AS286N	Samples
SNJ54AS286FK	OBSOLETE	LCCC	FK	20		TBD	Call TI	Call TI	-55 to 125		

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.



#### PACKAGE OPTION ADDENDUM

10-Jun-2014

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF SN54AS286, SN74AS286:

Catalog: SN74AS286

Military: SN54AS286

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

#### 14 LEADS SHOWN

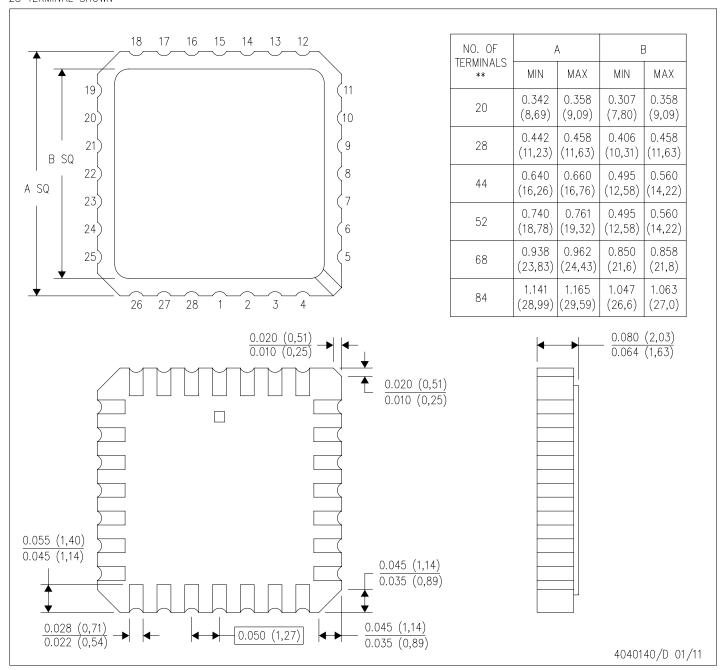


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

# FK (S-CQCC-N\*\*)

# LEADLESS CERAMIC CHIP CARRIER

28 TERMINAL SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a metal lid.
- D. Falls within JEDEC MS-004



# N (R-PDIP-T\*\*)

# PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



# D (R-PDSO-G14)

#### PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



# D (R-PDSO-G14)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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